

《微纳光电子材料与器件工艺实验》
Laboratory of Micro- and Nanofabrication for
Electronic and Photonic Devices

实验 3

刻蚀

Lab 3

Etching

Lecturer: Xing Sheng

Place: Weiqing Building 113

1. Objectives

In this lab, we introduce two different etching methods: the reactive ion etching (RIE) method to dry etch materials (silicon, SiO₂, photoresist), and wet etching method to remove SiO₂ films on Si. We will etch silicon, SiO₂ and photoresist respectively by SF₆, CHF₃ and O₂ plasma, observe and measure the etched patterns. In addition, we will etch SiO₂ films on Si by using buffered hydrofluoric acid (BHF), and observe the surface change from the hydrophilic state to the hydrophobic state.

2. Materials and Equipments

silicon pieces with SPR220-v3.0 photoresist patterns (> 10)
silicon pieces with SiO₂ layer on top (>10 pieces, by PECVD, thickness ~ 500 nm)
petri dish, 4 inch (>10)
plastic beakers (> 2)
gloves (>2 boxes)
face masks (>20)
cleanroom white papers (>1 bag)
wafer tweezers (>5)
buffered hydrofluoric acid solution (1:6) (also called BHF or BOE)
DI water bottle, acetone bottle, alcohol bottle

safety gowns for HF etching (face masks, aprons and rubber gloves)
RIE-100
Dektak-150 profilometer

3. Procedures

preparation:

- turn on N₂ gun
- turn on profilometer
- turn on RIE-100

RIE dry etch 1:

- hard bake the samples (PR on Si) at 110 C for 30 mins

- observe the silicon samples under microscope, measure the patterned photoresist (SPR220-v3.0) thickness
- etch the samples using SF₆ gas for 2 mins
- observe and measure the pattern thickness again, calculate the etched silicon thickness and etching rate
- remove the photoresist layer rinsing by acetone, alcohol and DI water
- observe and measure the pattern thickness again

RIE dry etch 2:

- etch another new Si sample with photoresist patterns using SF₆ gas for 2 mins
- observe and measure the pattern thickness
- etch the photoresist layer using O₂ gas for 3 mins
- observe and measure the pattern thickness again, calculate the etched photoresist thickness and etching rate
- etch the photoresist layer using O₂ gas for 12 mins, to completely remove the photoresist layer
- observe and measure the pattern thickness again
- run chamber clean process

wet etch:

- prepare buffered HF (BHF or BOE) solution on a plastic beaker
- test the water wetting ability on the silicon pieces with a SiO₂ layer
- dip the samples into BHF for about 3 mins
- observe the color change, and test the water wetting ability again

surface modification by plasma:

- treat the HF cleaned Si sample with O₂ plasma for 2 mins
- test the water wetting ability again

4. Results

Thickness of PR on Si = _____ nm

After 2 mins SF₆ RIE, step height = _____ nm

Estimated etch rate for Si by SF₆ = _____ nm/min

(1) After clean PR with acetone, step height = _____ nm
actual etch rate for Si by SF₆ = _____ nm/min

(2) After 3 mins O₂ RIE, step height = _____ nm
estimated etch rate for PR by O₂ = _____ nm/min
After clean PR with O₂ RIE, step height = _____ nm
actual etch rate for Si by SF₆ = _____ nm/min

Etch rate of PECVD SiO₂ in BHF = _____ nm/min

附录一：反应离子刻蚀设备的使用

一 开机（使用前先网上预约）

依次打开机台前面板上的电源开关、循环水机的电源开关、空气压缩机的电源开关、再打开所需要的工艺气体的开关（面板最上面的旋钮旋到 open），并检查减压阀主表压力（ $> 0.5 \text{ MPa}$ ）和副表压力（ $0.1-0.2 \text{ MPa}$ ）；

二 软件操作及工艺过程

- 双击桌面上的 RIE.exe;
- 软件开机自检;
- “真空流程”，机台自动进行抽真空流程，结束后弹窗提示;
- “充气开盖”，机台自动进行充气流程，流程结束并弹窗提示;
- 打开上盖，放入样品，关闭上盖;
- “真空流程”，机台自动进行抽真空流程，结束后弹窗提示;
- “加载工艺”，自动加载选定的工艺菜单;
- “运行工艺”，工艺自动开始运行，做好工艺记录，工艺结束;
- “真空系统”，选择”关闭高阀”，等待高阀关闭;
- ”充气开盖”，流程结束并弹窗提示;
- 取出样品，做下一个样品直至结束实验，关闭上盖
- “真空流程”，机台自动进行抽真空流程，结束后弹窗提示;
- “真空系统”，选择”关闭泵组”，机台自动关闭泵组并停止抽真空，分子泵转数降到 0 以后弹出窗提示;
- 点击退出，电脑关机;

三 关机

依次关闭工艺气体（面板最上面的旋钮旋到 close，气瓶和减压阀不关）、空气压缩机的电源（出气阀不关）、循环水机的电源（进出水阀门不关）、最后关闭机台前面板的电源

四 整理台面保持卫生，做好实验记录

备注:

1) 工艺开始前气体和射频有一定的延时稳定时间, 当前步计时开始为工艺开始的标志。

2) “停止工艺” 按键是在工艺进行中立即结束工艺。停止工艺按键只有在工艺开始后才能使用。

3) 自动流程之间有互锁, 任何流程进行中不要再次点击流程按键, 否则弹窗提示“请等待当前进程结束”。

4) “结束进程” 按键是立即结束当前进程。正在运行的自动流程会立即停止在当前状态。按下此按键后必须关闭整个程序后再重新启动, 才能运行自动流程。此按键只有在需要强制退出自动流程并关机的情况下才能使用。

5) 水、气注意事项:

- 气瓶的开关和减压阀一直保持开启状态, 使用时只开关最上面的那个阀门 (写有 **Open - Close** 字样), 工作时减压阀副表压力应保持在 **0.1-0.2MPa** 之间, 主表压力不低于 **0.5MPa**;

- 循环水机的进出水阀门一直保持开启状态, 使用时只开关电源;

- 空气压缩机的出气阀门一直保持开启状态, 压力保持 **0.5MPa** 使用时只开关电源;

- 真空泵的开关在软件中控制